

# Impact of Hygrothermal Behavior on Optimal Requirements and Testing

**CEEES Seminar 26.9.2008**

**“Management of Verified Environmental Stresses”**

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# Outline

- **Background and Objectives**
- **Theoretical response models**
  - Temperature and Humidity
- **Semi-empirical response model**
  - Takes into account absorption and desorption of water to materials
- **Requirement and test optimization**
  - Device characteristics
  - Usage environment
  - Device response
  - Optimal test
- **Conclusions**

# Background and Objectives

## Drivers / Motivation:

- Cost saving through optimal requirements and that way optimal design
- Cost saving through optimal testing, maximal acceleration (minimal test time) and effective finding or relevant failures in tests

## Background:

- Packaging of outdoor electronics in Hot and humid environments
- Mechanics and materials of device effect on in-device environment and transients – i.e. in-device stresses
- Hygro-thermal response of device has to be know for ensuring optimal environmental requirement and test procedure

## Objectives

- To study experimentally device responses for T and Humidity
- To analyze effect findings on internal conditions of device in real usage
- To conclude potential impact of findings on environmental requirements and testing

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# Theoretical response models: Hygrothermal Model

**Step change in vapour density i.e. humidity concentration,  
constant temperature**

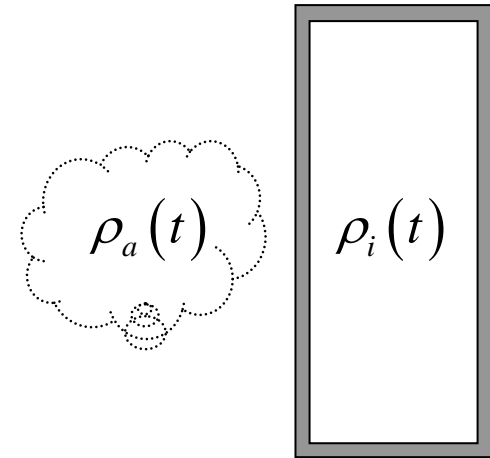
Fick's Second Law

Quasi- steady-state approximation\*

$$\frac{\partial \rho_i(t)}{\partial t} = \frac{1}{\tau_C} (\rho_i(t) - \rho_a(t))$$

For a step change:

$$\rho_i(t) = \rho_a - (\rho_a - \rho_i^0) \exp(-t/\tau_C)$$



Characteristic parameter is Mass transfer time constant,  $\tau_C$

\* Tencer, M., 1994, "Moisture Ingress into Nonhermetic Enclosures and Packages: A Quasi-Steady State Model for Diffusion and Attenuation of Ambient Humidity Variations", Proc. 44th ECTC, pp. 196-209.

# Theoretical response models:

## Hygrothermal Model

### Mass transfer time constant, $t_c$

Function of:

- Enclosure volume,  $V$  • Surface area,  $A$  • Wall thickness,  $L$
- Permeability,  $P$
- Diffusion coefficient,  $D$

$$\tau_c = VL/AP + L^2/2D$$

- Thin, non absorbing walls;
- Enclosure volume  $\gg$  wall volume  
→ Permeability is critical

- Thick, absorbing walls;
- Wall volume  $>$  enclosure volume  
→ Diffusion coefficient is critical

# Theoretical response models: Hygrothermal Model

## Step change in temperature, constant vapour density

One-dimensional, transient heat transfer

Lumped-capacity approximation, for a step change:

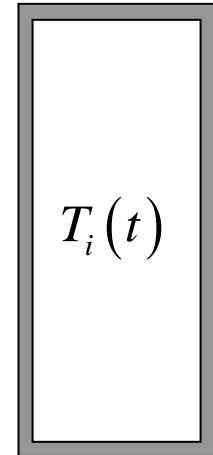
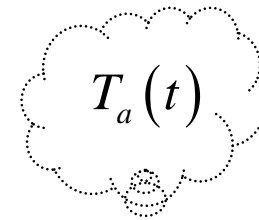
$$T_i(t) = T_a - (T_a - T_i^0) \exp(-t / \tau_T)$$

## Thermal time constant, $\tau_T$

$$\tau_T = R_{th} C_{th}$$

Where

- $R_{th}$  = thermal resistance
- $C_{th}$  = thermal capacitance



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# Analysis: Hygrothermal Model

## Temperature rise, constant $\rho$

Time 0  $\rightarrow$  **equilibrium**

Period 1  $\rightarrow$  **Desorption of moisture** from hygroscopic materials

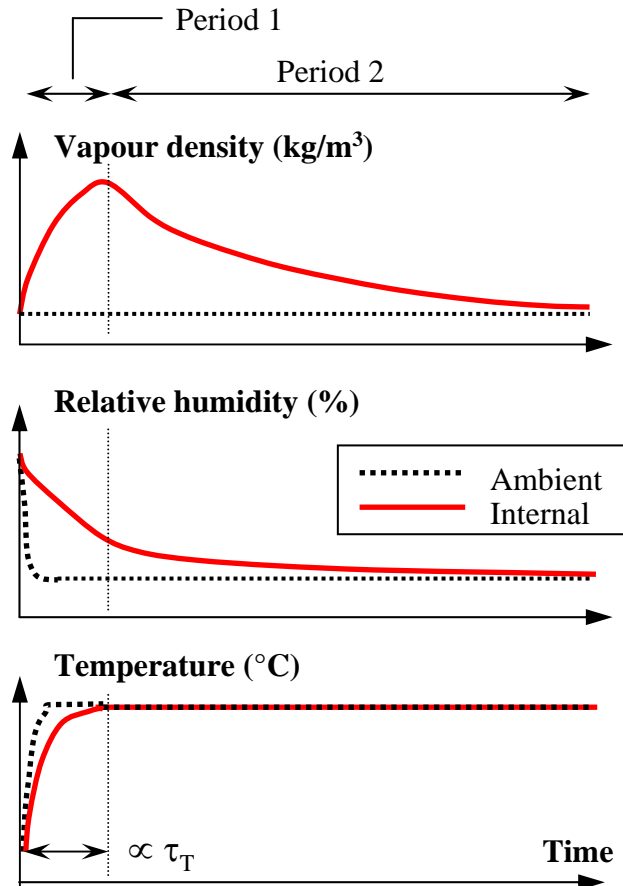
Period 2  $\rightarrow$  **Thermal equilibrium**, mass transfer to ambient

Semi-empirical form\*:

$$\frac{\partial \rho_i(t)}{\partial t} = \frac{1}{\tau_c} (\rho_i(t) - \rho_a(t)) - C^* \left( \frac{1}{T_i(t)} - \frac{1}{T_a(t)} \right)$$

$\text{kgK/m}^3 \text{ s}$

In general, significance of semi-empirical term increases when  $V \ll A$



\* Punch, J., Grimes, R., Heaslip, G., Galkin, T., Väkeväinen, K., Kyyhkynen, V. and Elonen, E., 2005, "Transient Hygrothermal Behaviour of Portable Electronics", IEEE EuroSIME 2005: Thermal, Mechanical and Multi-physics Simulation and Experiments in Micro-electronics and Micro-systems, pp. 398-405.

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# Procedure for optimal Temperature & Humidity requirement and testing

## 1. Device characteristics

- Time constant for Temperature
- Time constant for Humidity
- Absorption and desorption considered

## 2. Usage environment

- Meteorological data analysis
- Events, which can effect on internal environment

## 3. Device response

- Response models
- Input data: Experimental time constants and meteorological data
- Effect of events → experimentally

## 4. Optimal requirement and test

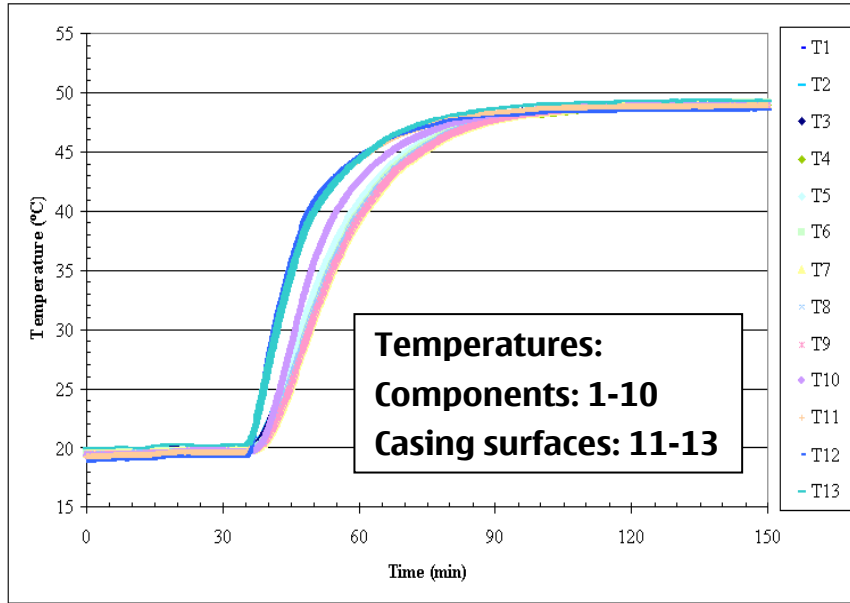
- Requirements from device responses
- Test for replicate in-device stresses in field

\* Punch, J., Galkin, T., Ojala K., Rodgers, B., 2006 “The Hygrothermal Behaviour of Outdoor Electronic Equipment in Time-Varying Hot and Humid Weather Conditions”, IEEE ASTR 2006: Workshop on Accelerated Stress Testing & Reliability



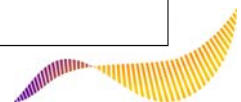
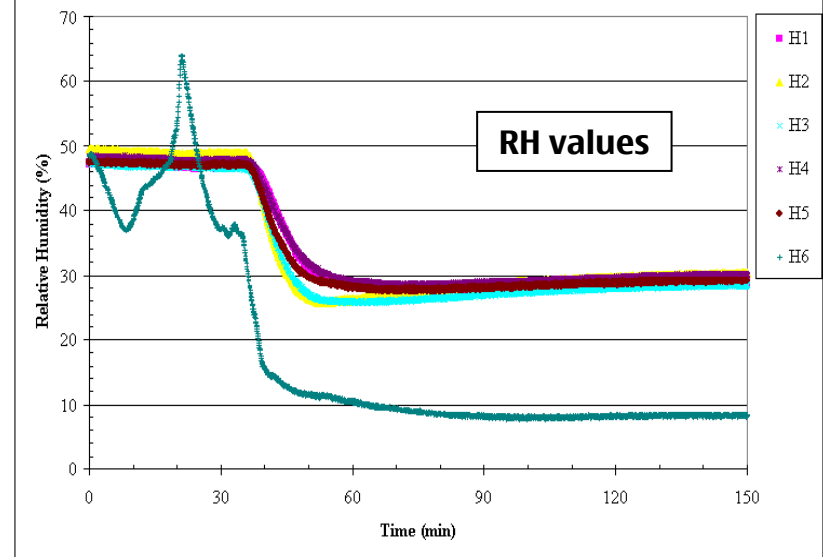
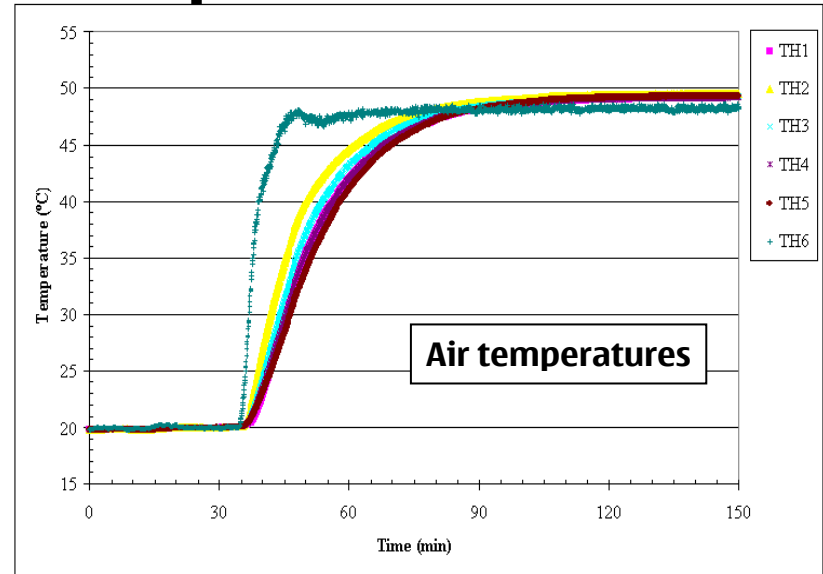
# Optimal environmental test

## 1. Device characteristics – Temperature



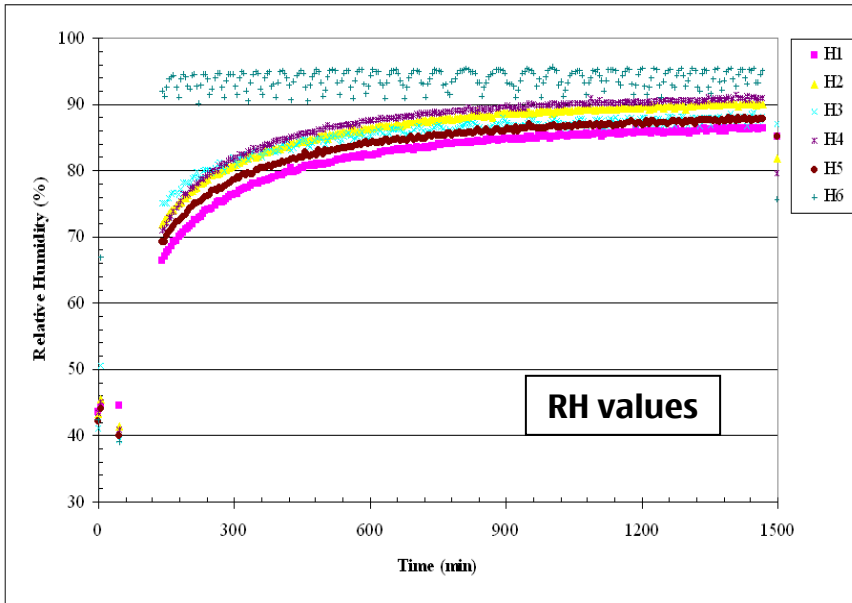
- T-step 20→50°C: Unit in chamber at ambient RH (40%), apart from 'spike' at ~20min
- **Thermal time constants (minutes):**
  - **Components:** 17.09–19.92 (Mean 18.55)
  - **Air temps.:** 16.50–18.25 (Mean 17.60)
  - **Initial thermal constants for components**
- **Stabilisation time ≈ 54 minutes**

**IMPACT ON TEST: Optimal Dwell Times**

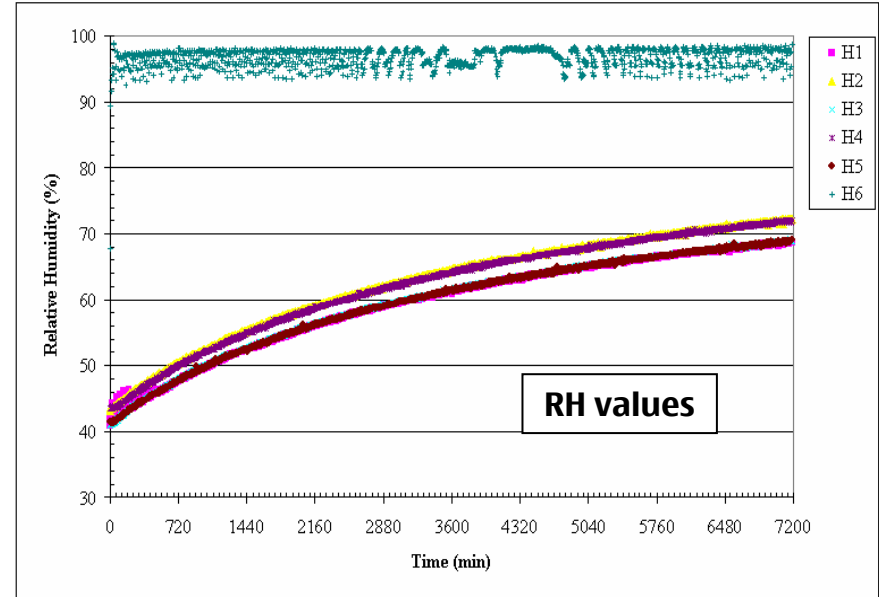


# Optimal environmental test

## 1. Device characteristics – Humidity



Aperture Open



Aperture Closed

- In each case, the Unit was started at nominal 20°C, 40%RH
  - Step to 20°C, 90%RH
- **Humidity time constant (hours):**
  - **Aperture Open: 10.72–20.28 (Mean 15.75 → 0.66 days)**
  - **Aperture Closed: 163.93–185.19 (Mean 175.34 → 7.31 days)**

**IMPACT ON TEST: Time constant has to be considered in in-device humidification**

# Optimal environmental test

## 2. Usage environment

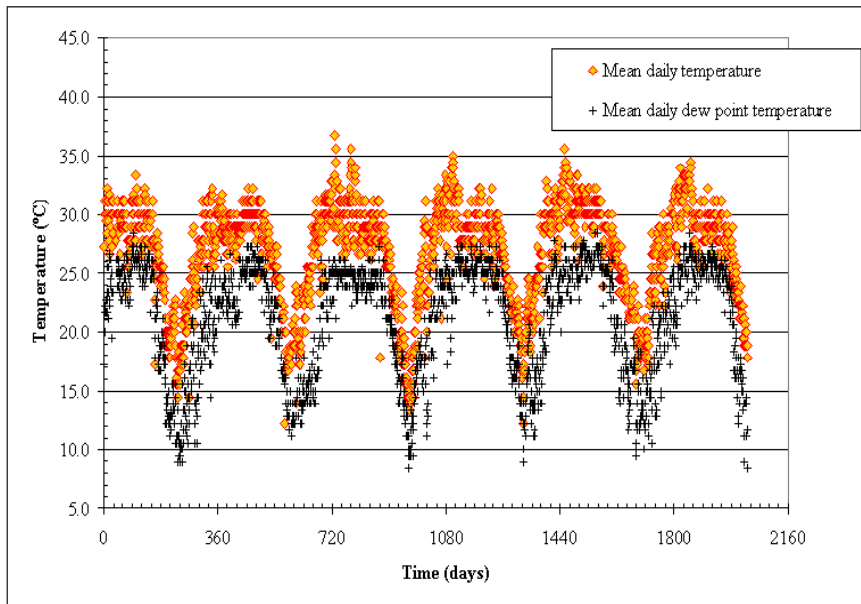
### Meteorological data: T & RH

#### Reference environment 1:

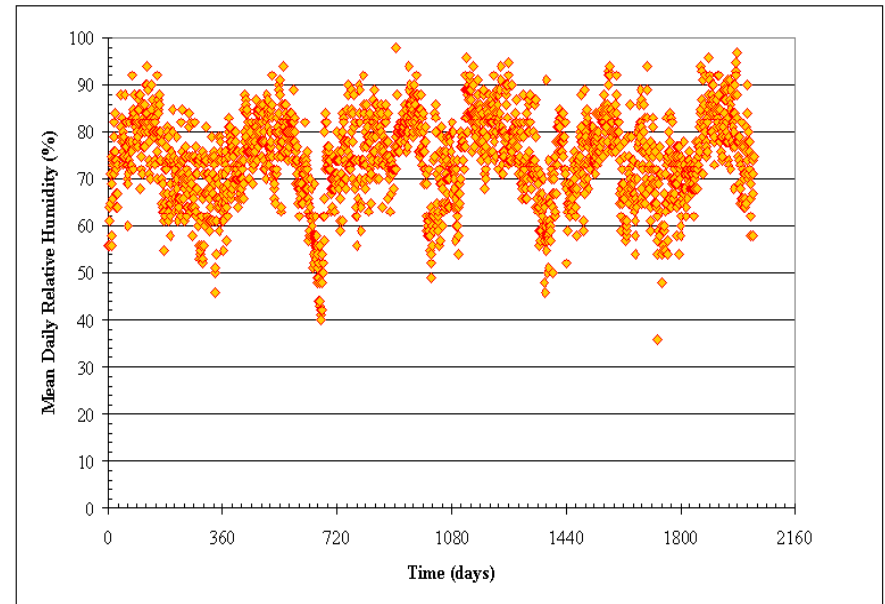
- Warm temperature, Hot summer (Heavy rain fall events: Annual mean 69), Dry winter

Over 5 years (2000 – 2005) climatic data

#### IMPACT ON TEST & REQ.: T(max), T(min), annual humidity cycles



Mean daily values of temperature and dew point temperature



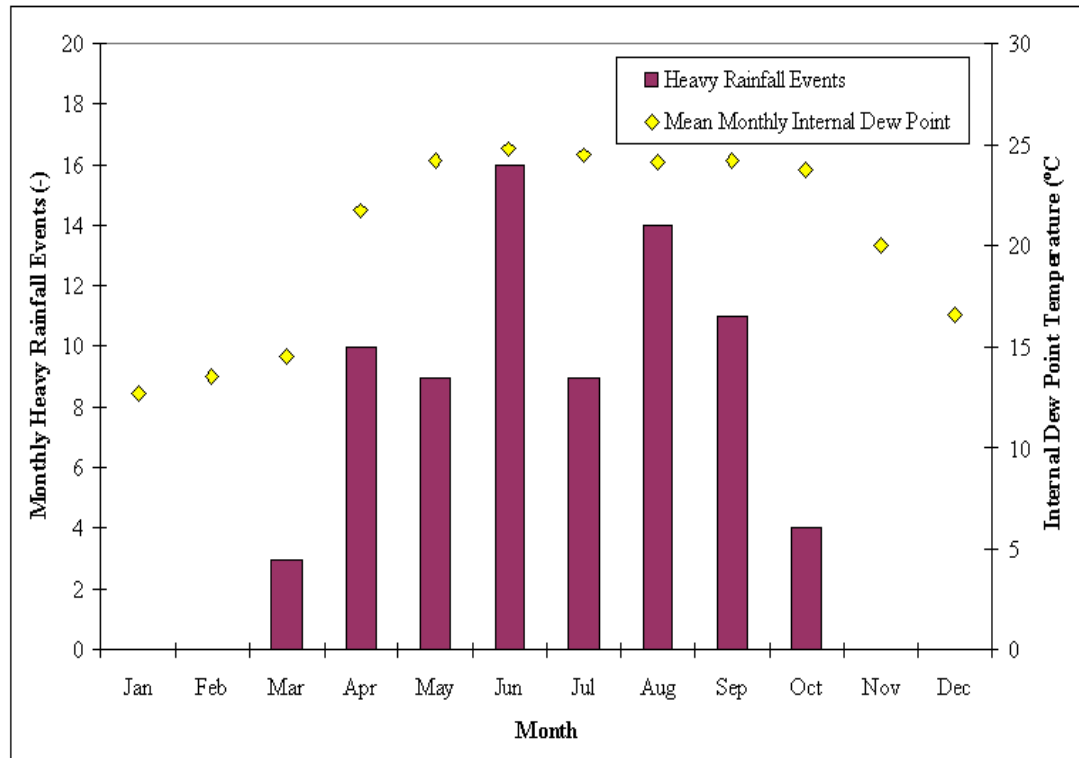
Mean daily values of relative humidity

**Average daily level of relative humidity: 74.3%**

# Optimal environmental test

## 2. Usage environment – Events

Most of rainfalls in high humidity season → High Risk of Condensation



Monthly numbers of heavy rainfall events and predicted mean monthly internal dew point temperature

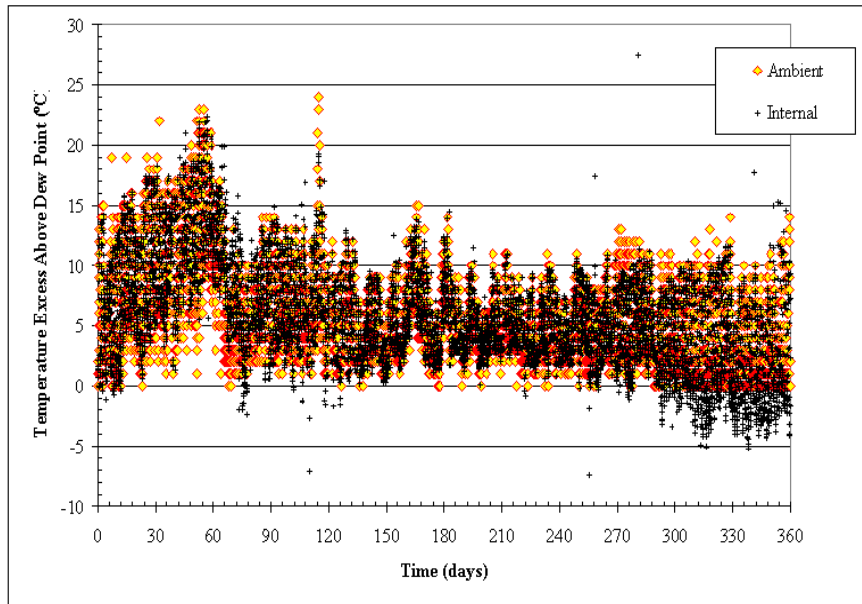
# Optimal environmental test

## 3. Device Response – In-device conditions

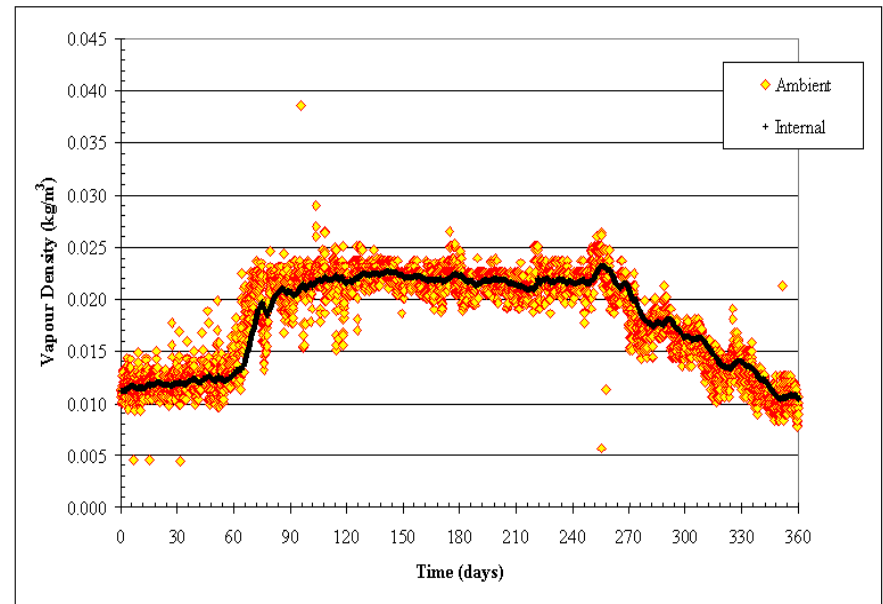
### Meteorological Data – Reference environment 1

Vapour density response is damped

**IMPACT ON TEST & REQ.:** Long humid period → humidity gets into device



**Predicted temperature excess above dew point**



**Predicted vapour density response**  
→ **Note:** 200 days high water vapour density period → time enough for humidity diffuse into device

# Optimal environmental test

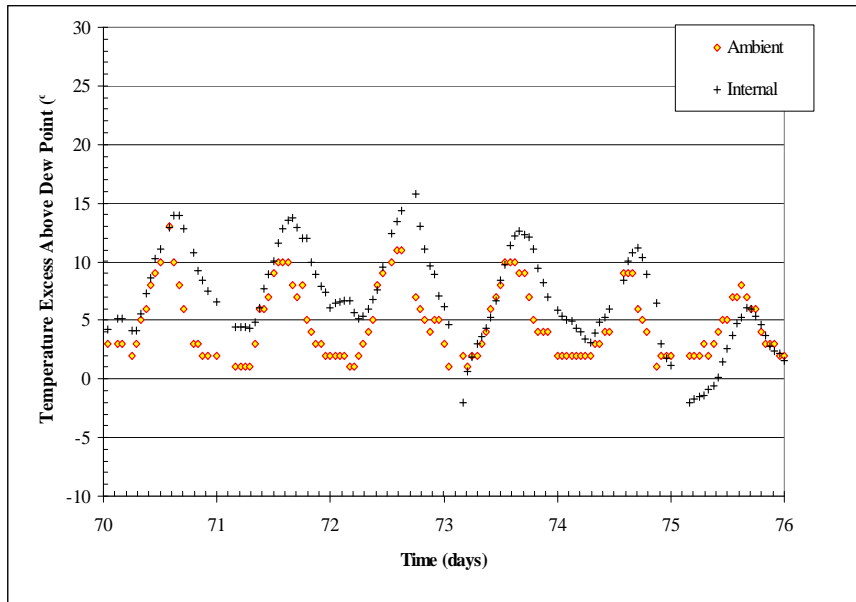
## 3. Device response – Ramp rates

### Meteorological Data – Reference environment 1

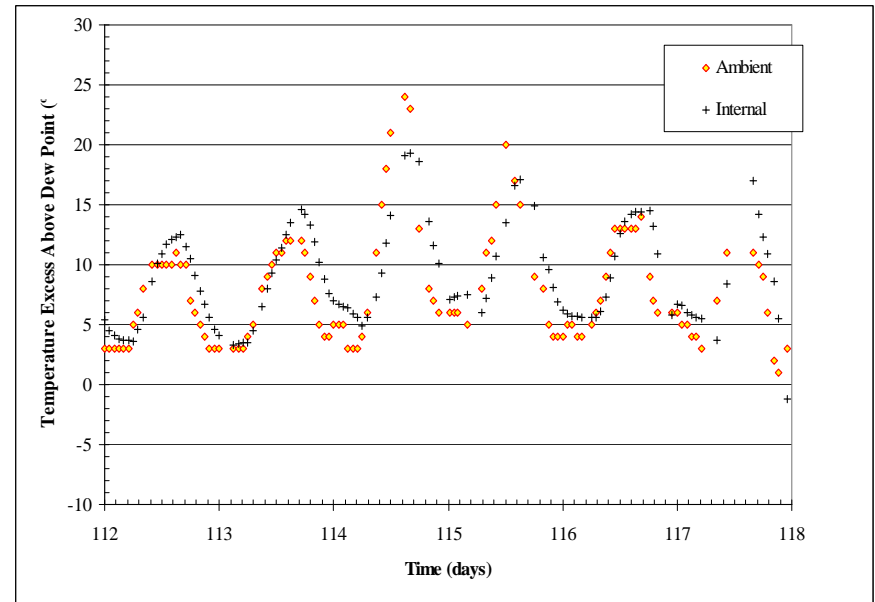
Predicted temperature excess above dew point

6 day data excerpts

### IMPACT ON TEST: Real ramp rates of T in device and components



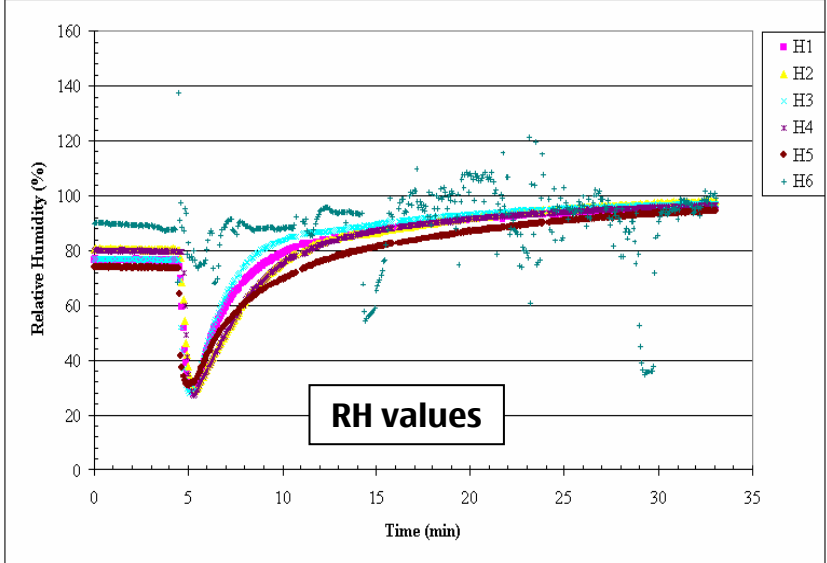
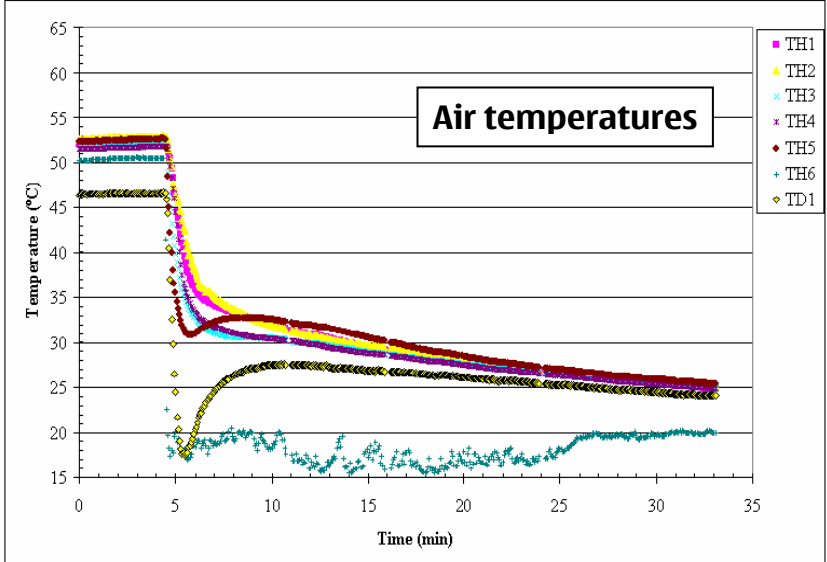
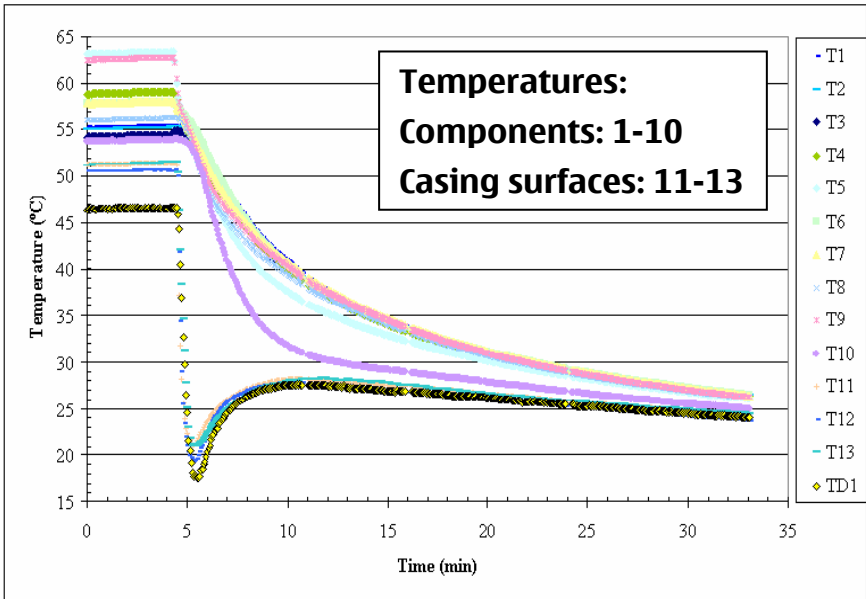
**Vapor density ramp-up period**



**High vapor density period**

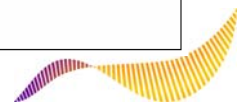
# Optimal environmental test

## 3. Device response – Events / Rainfall



- Unit stable at 50°C, 72-80%RH, *Power On*
- Simultaneously: *Power Off*, open chamber and apply 'rain' at 18.1°C for 1 min
- Sensor data indication → Drop in internal RH is evidence of moisture condensing

**IMPACT ON TEST & REQ.:** Rainfall can evidently induce condensation



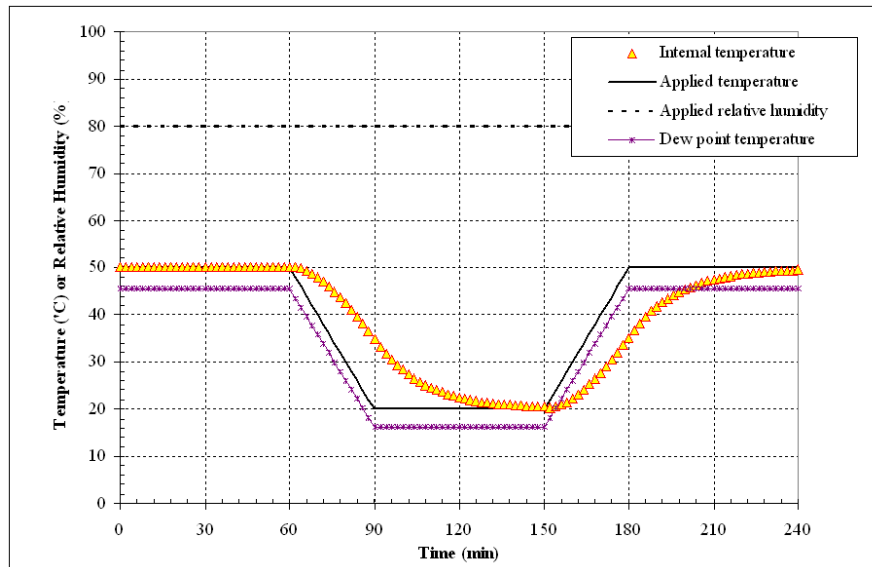
# Optimal environmental test

## 4. Optimal test – Numerical simulation

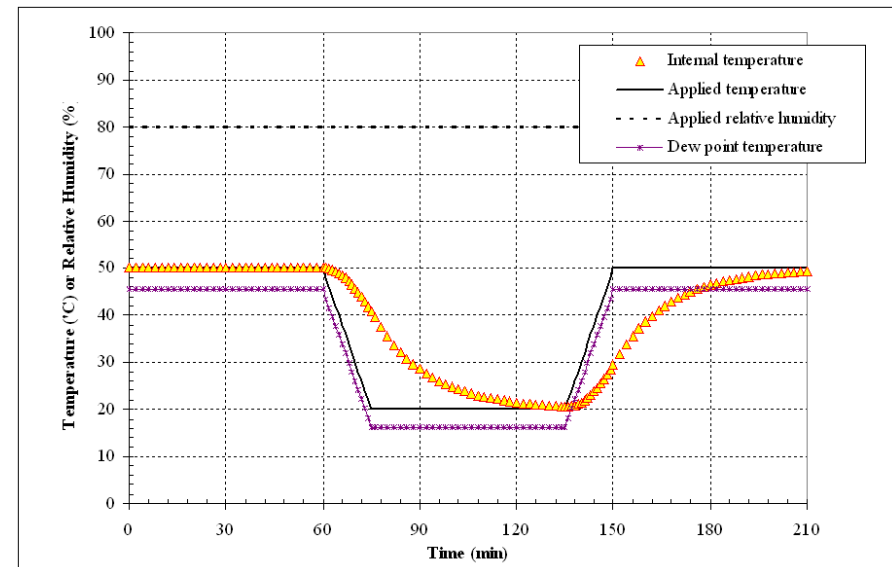
### Condensation Test

Predicted Hygrothermal Response

'Pre-humidified' Unit (50°C, 80%RH)



Response to condensation test with 1°C/min ramp rates, 50°C to 20°C limits.

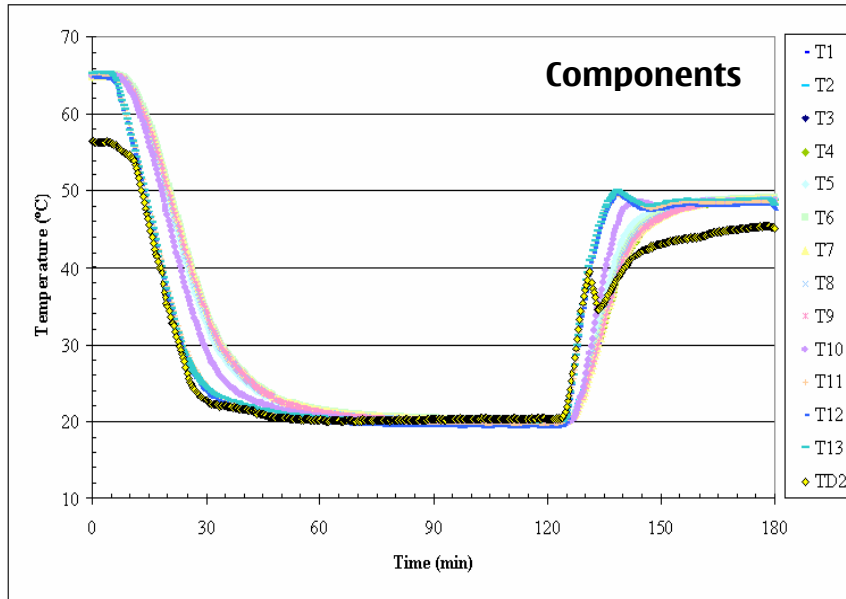


Response to condensation test with 2°C/min ramp rates, 50°C to 20°C limits.

**A minimum dwell time at low temperature is required in order to induce condensation**

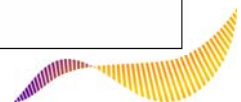
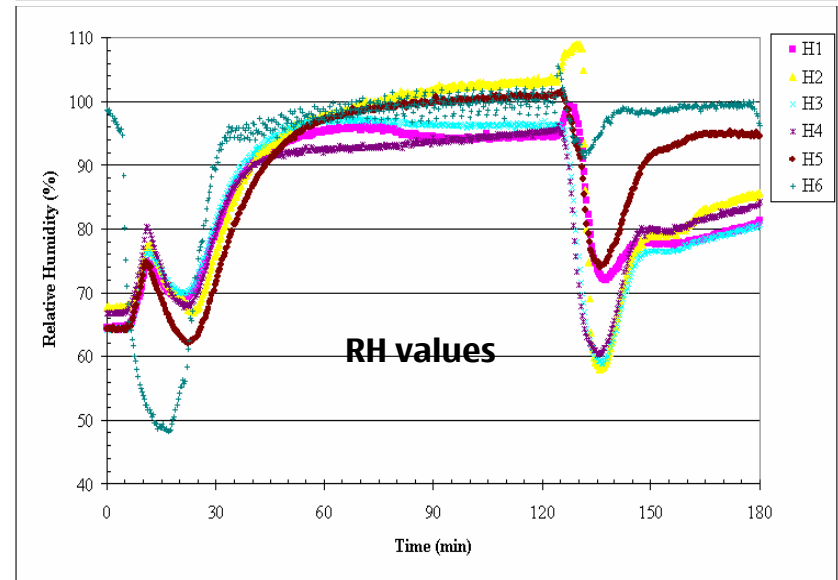
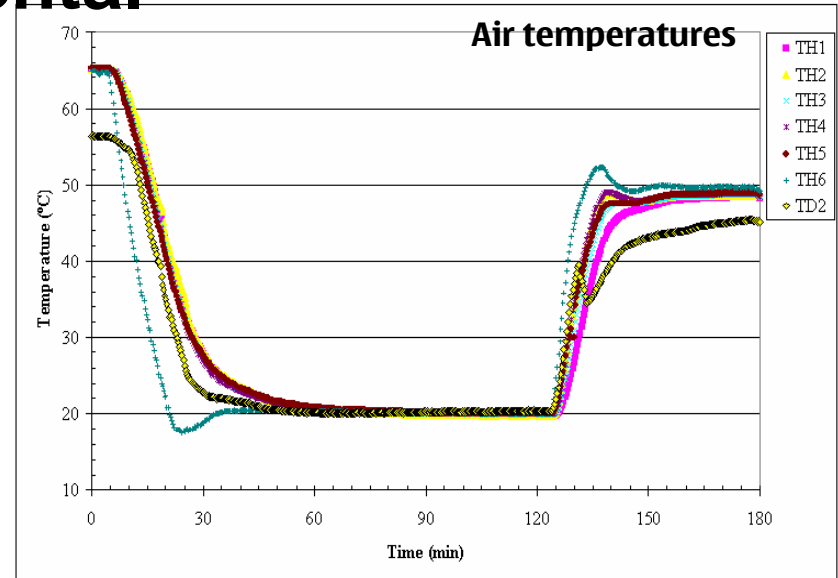
# Optimal environmental test

## 4. Optimal test – Experimental



- Unit 'pre-humidified' to 65°C, 64-68%RH
- 65°C→20°C→50°C in steps
- Constant set-point 95%RH
- Highest dew point (TD2) shown on temperature plots to indicate – is evident of possibility of condensation

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# Conclusions

- Temperature and humidity requirements optimization procedure was introduced
- Response models, device characteristics and climatic data can be combined for requirement and test optimization by following procedure
  1. Measure device responses
  2. Calculate time constants (T & Humidity) from measurement data
  3. Analyze climatic data
  4. Calculate, pilot test and conclude general and worst cases in-device stresses
  5. Conclude effects of findings on requirements
  6. Optimize test procedure so that all the relevant stresses are included
- Requirement and test optimization enable cost reduction
- Ultimate target is to create device design optimization guidelines for use environment - optimized requirements and tests are enablers for that

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# THANK YOU!

## Questions or Comments?

Timo Galkin

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